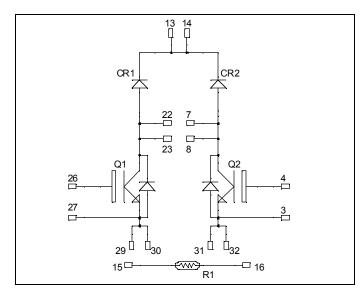
Dual Boost chopper Trench IGBT® Power Module





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All multiple inputs and outputs must be shorted together Example: 13/14; 29/30; 22/23 ...

Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

Features

- Trench + Field Stop IGBT® Technology
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 20 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - Avalanche energy rated
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCEsat
- Each leg can be easily paralleled to achieve a single boost of twice the current capability.

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V_{CES}	Collector - Emitter Breakdown Voltage		1200	V
L	Continuous Collector Current	$T_C = 25^{\circ}C$	75	
I_{C}	T _C =	$T_C = 80$ °C	50	Α
I_{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V_{GE}	Gate – Emitter Voltage		±20	V
P_{D}	Maximum Power Dissipation	$T_C = 25^{\circ}C$	270	W
RBSOA	Reverse Bias Save Operating Area	$T_{J} = 125^{\circ}C$	100A @ 1150V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed.



All ratings @ $T_j = 25$ °C unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$\mathrm{BV}_{\mathrm{CES}}$	Collector - Emitter Breakdown Voltage	$V_{GE} = 0V$, $I_C = 2mA$		1200			V
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1200V$				5	mA
V	Collector Emitter on Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$	1.4	1.7	2.1	V
V _{CE(on)}	Concetor Emitter on Voltage	$I_{\rm C} = 50 {\rm A}$ $T_{\rm j} = 125 {\rm °C}$			2.0		·
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C =$	2mA	5.0	5.8	6.5	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20 V, V_{CE} = 0 V$				400	nA

Dynamic Characteristics

•	Characteristic	Test Conditions	Min	Typ	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0 V, V_{CE} = 25 V$		3600		pF
C_{rss}	Reverse Transfer Capacitance	f = 1 MHz		160		PΓ
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C)		90		
T _r	Rise Time	$V_{GE} = \pm 15V$		30		ns
T _{d(off)}	Turn-off Delay Time	$V_{\text{Bus}} = 600V$ $I_{\text{C}} = 50A$		420		115
$T_{\rm f}$	Fall Time	$R_G = 18\Omega$		70		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)		90		ns
T _r	Rise Time	$V_{GE} = \pm 15V$		50		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 600V$ $I_{\text{C}} = 50A$		520		115
$T_{\rm f}$	Fall Time	$R_G = 18\Omega$		90		
Eon	Turn-on Switching Energy •	$R_{\rm G} = 1822$		5		mJ
E_{off}	Turn-off Switching Energy 2			5.5		111)

- E_{on} includes diode reverse recovery
 In accordance with JEDEC standard JESD24-1

Diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Test Conditions		Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	$V_{\rm p} = 1200 {\rm V}$	$T_j = 25^{\circ}C$			250	Δ
1RM	Waximum Reverse Leakage Current		$T_{j} = 125^{\circ}C$			500	μΑ
$I_{F(A V)}$	Maximum Average Forward Current	50% duty cycle	$Tc = 70^{\circ}C$		60		A
	Diode Forward Voltage	$I_F = 60 A$			2	2.5	
$V_{\rm F}$		$I_F = 120A$			2.3		V
		$I_F = 60 \mathrm{A}$	$T_j = 125$ °C		1.8		
t_{rr}	Reverse Recovery Time	$I_{\rm F} = 60 \text{A}$	$T_j = 25$ °C		400		ns
ur ur	$I_F = 60A$ $V_R = 800V$		$T_{\rm j} = 125^{\circ}{\rm C}$		470		
Qrr	Reverse Recovery Charge	$di/dt = 200 A/\mu s$	$T_j = 25$ °C		1200		nC
Qп	Reverse Recovery Charge		$T_j = 125^{\circ}C$		4000		



Temperature sensor NTC

Symbol	Characteristic	Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C		68		kΩ
B _{25/85}	$T_{25} = 298.16 \text{ K}$		4080		K

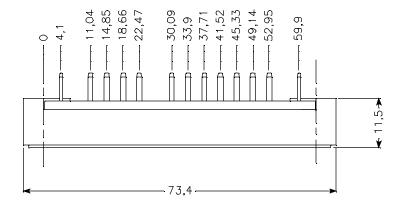
$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$

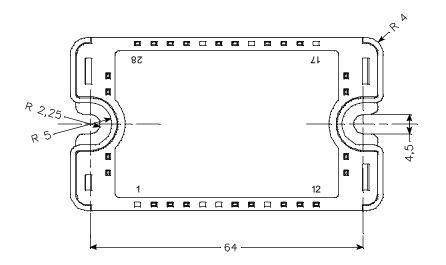
$$R_T: \text{Thermistor value at T}$$

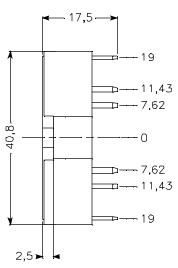
Thermal and package characteristics

Symbol	Characteristic			Min	Typ	Max	Unit	
R_{thJC}	Junction to Case		IGBT		1	0.45	°C/W	
KthJC			Diode			0.9	C/ VV	
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, I isol<1mA, 50/60Hz			2500			V	
T_{J}	Operating junction temperature range Storage Temperature Range		-40		150			
T_{STG}			-40	·	125	°C		
$T_{\rm C}$	Operating Case Temperature			-40		100		
Torque	Mounting torque	To heatsink	M4			4.7	N.m	
Wt	Package Weight	·				110	g	

Package outline

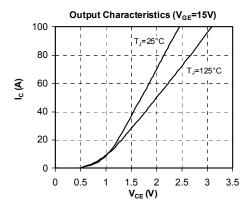


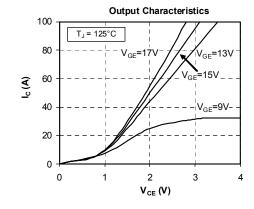


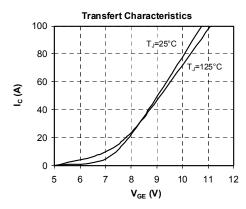


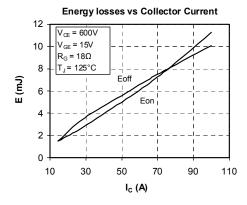


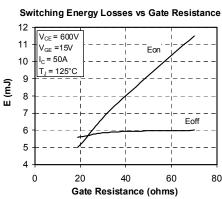
Typical Performance Curve

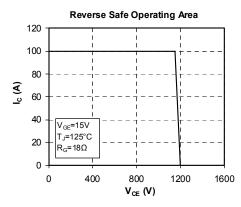


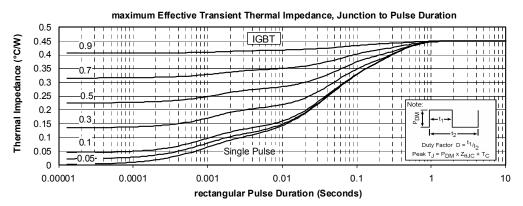


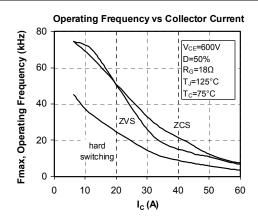


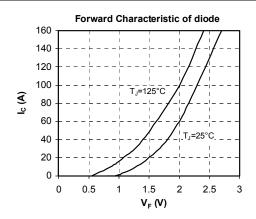


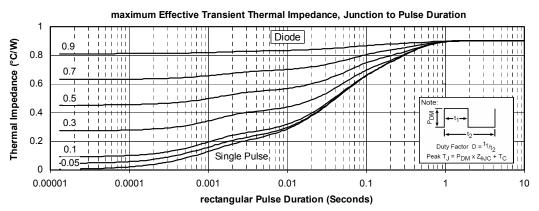












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